Se	arch	Note	S

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,243	JUBRAN ET AL.	
Examiner	Art Unit	
Christopher RoDee	1756	

SEARCHED			
Class	Subclass	Date	Examiner
430	73 79 74 78	5/15/2006	CDR
548	444	5/15/2006	CDR
546	95	5/15/2006	CDR
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN structure search as enclosed	5/15/2006	CDR